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| Notice of References Cited | Application/Control No. 10/075,640 | Applicant(s)/Patent Under Reexamination NUTTALL ET AL. | |
| | Examiner DAVID VU | Art Unit 2818 | Page 1 of 1 |

U.S. PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Name | Classification |
|---|---|--|-----------------|-------------------|----------------|
| * | A | US-5,854,105 | 12-1998 | Tseng, Horng-Huei | 438/253 |
| * | B | US-5,766,994 | 06-1998 | Tseng, Horng-Huei | 438/254 |
| * | C | US-6,137,130 | 10-2000 | Sung, Janmye | 257/306 |
| * | D | US-6,130,102 | 10-2000 | White et al. | 438/3 |
| * | E | US-6,001,709 | 12-1999 | Chuang et al. | 438/440 |
| | F | US- | | | |
| | G | US- | | | |
| | H | US- | | | |
| | I | US- | | | |
| | J | US- | | | |
| | K | US- | | | |
| | L | US- | | | |
| | M | US- | | | |

FOREIGN PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Country | Name | Classification |
|---|---|--|-----------------|---------|------|----------------|
| | N | | | | | |
| | O | | | | | |
| | P | | | | | |
| | Q | | | | | |
| | R | | | | | |
| | S | | | | | |
| | T | | | | | |

NON-PATENT DOCUMENTS

| * | | Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) |
|---|---|---|
| | U | |
| | V | |
| | W | |
| | X | |

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